

A3G75N1200MT4S

1200V N-Channel MOSFET, 75A, 30mΩ



Features

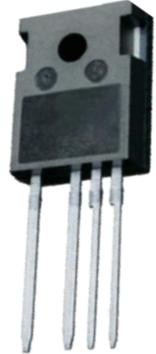
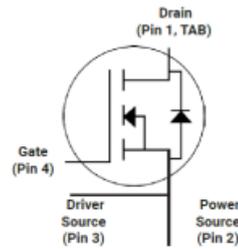
- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low $R_{DS(on)}$
- Optimized package with separate driver source pin
- Easy to parallel and simple to drive
- ROHS Compliant, Halogen free

Application

- EV motor drive
- High Voltage DC/DC Converters
- Switch Mode Power Supplies
- Solar inverters
- EV charging

V_{DS}	1200V
I_D	75A

Product Summary



Ordering Information

Part Number	Marking	Package	Packaging
A3G75N1200MT4S	A3G75N1200MT4S	TO-247-4S	Tube



Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-Source Voltage	1200	V
I_D	Drain Current (continuous) at $T_C=25^\circ\text{C}$	75	A
I_D	Drain Current (continuous) at $T_C=100^\circ\text{C}$	55	A
I_{DM}	Drain Current (pulsed)	188	A
V_{GS}	Gate-Source Voltage	-10/+22	V
P_D	Power Dissipation $T_C=25^\circ\text{C}$	375	W
T_J, T_{stg}	Junction and Storage Temperature Range	-55 to +175	$^\circ\text{C}$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Typical Performance-Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV_{DS}	Drain-source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	1200			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=1200\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$		5	100	μA
I_{GSS}	Gate-body Leakage Current	$V_{DS}=0\text{V}, V_{GS}=-10$ to 20V		10	250	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=20\text{mA}$	1.8	2.5	3.6	V
V_{GSon}	Recommended turn-on Voltage	Static		15/18		V
V_{GSoff}	Recommended turn-off Voltage			-5		V
$R_{DS(on)}$	Static Drain-source On Resistance	$V_{GS}=15\text{V}, I_D=38\text{A}$		36	43	$\text{m}\Omega$
		$V_{GS}=15\text{V}, I_D=38\text{A}, T_J=175^\circ\text{C}$		54		$\text{m}\Omega$
		$V_{GS}=18\text{V}, I_D=38\text{A}$		30	36	$\text{m}\Omega$
		$V_{GS}=18\text{V}, I_D=38\text{A}, T_J=175^\circ\text{C}$		45		$\text{m}\Omega$

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Typical Performance-Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C _{iss}	Input Capacitance	V _{DS} =1000V, f=1MHz V _{AC} =25mV		2950		pF
C _{oss}	Output Capacitance			128		pF
C _{rss}	Reverse Transfer Capacitance			7.8		pF
g _{fs}	Transconductance	V _{DS} =20V, I _D =38A		23		S
E _{OSS}	C _{oss} Stored Energy	V _{DS} =1000V, f=1MHz		72		uJ
E _{ON}	Turn-On Energy (Body Diode)	V _{DS} =800V		798		uJ
E _{OFF}	Turn-Off Energy (Body Diode)	V _{GS} =-5/18V, I _D =38A L=100uH, T _J =175°C		115		uJ
Q _g	Total Gate Charge	V _{DS} =800V		120		nC
Q _{gs}	Gate-source Charge	V _{GS} =-5/18V		44		nC
Q _{gd}	Gate-Drain Charge	I _D =38A		35		nC
R _{G(int)}	Internal Gate Resistance	f=1MHz, V _{AC} =25mV		1.6		Ω
t _{d(on)}	Turn-on Delay Time	V _{DS} =800V V _{GS} =-5/18V, I _D =38A L=100uH, R _{ext} =2.5Ω		16		ns
t _r	Rise Time			23		ns
t _{d(off)}	Turn-off Delay Time			28		ns
t _f	Fall Time			12		ns

Typical Performance-Reverse Diode (T_J=25°C unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _{FSD}	Forward Voltage	V _{GS} =0V, I _F =20A, T _J =25°C		3.6	6	V
		V _{GS} =0V, I _F =20A, T _J =175°C		3.2	6	V
I _S	Continuous Diode Forward Current	V _{GS} =0V, T _C =25°C		68		A
t _{rr}	Reverse Recovery Time	V _{GS} =-5V, I _F =58A		55		ns
Q _{rr}	Reverse Recovery Charge	V _R =800V		788		nC
I _{rrm}	Peak Reverse Recovery Current	di/dt=1780A/μs, T _J =175°C				A

Thermal Characteristics

Symbol	Parameter	Value	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	0.48	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	40	°C/W

The values are based on the junction-to case thermal impedance which is measured with the device mounted to a large heat sink assuming maximum junction temperature of T_{J(max)}=175°C.

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Electrical Characteristics

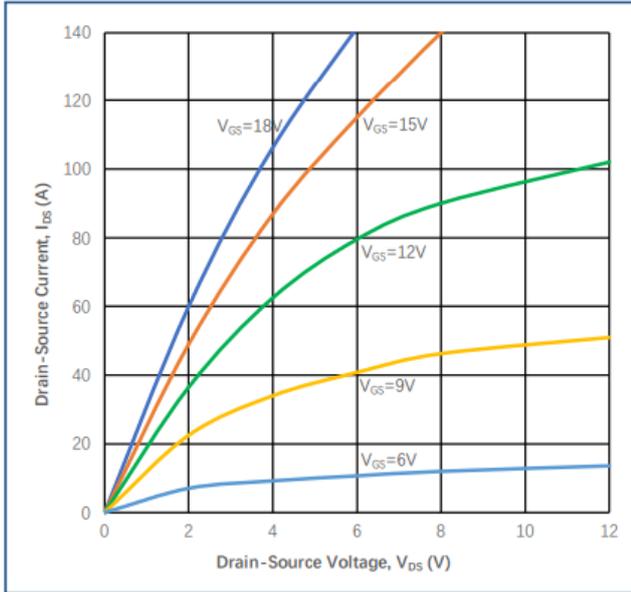


Figure 1
Output Characteristics (T_J=25 °C)

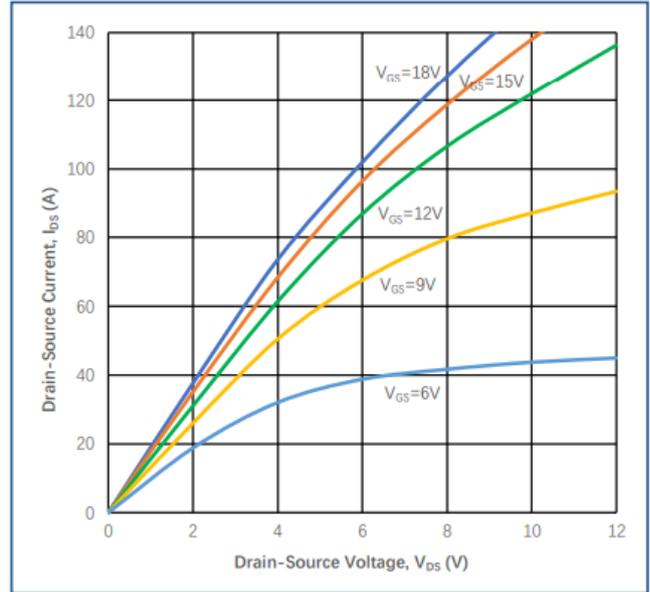


Figure 2
Output Characteristics (T_J=175 °C)

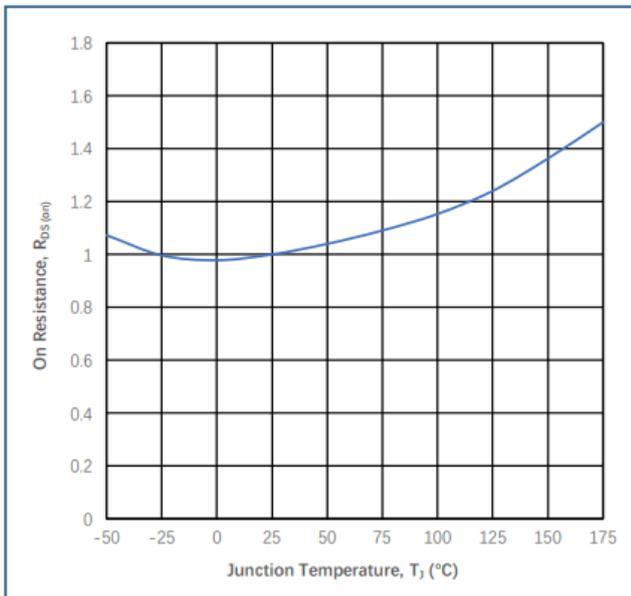


Figure 3
Normalized On-Resistance vs. Temperature

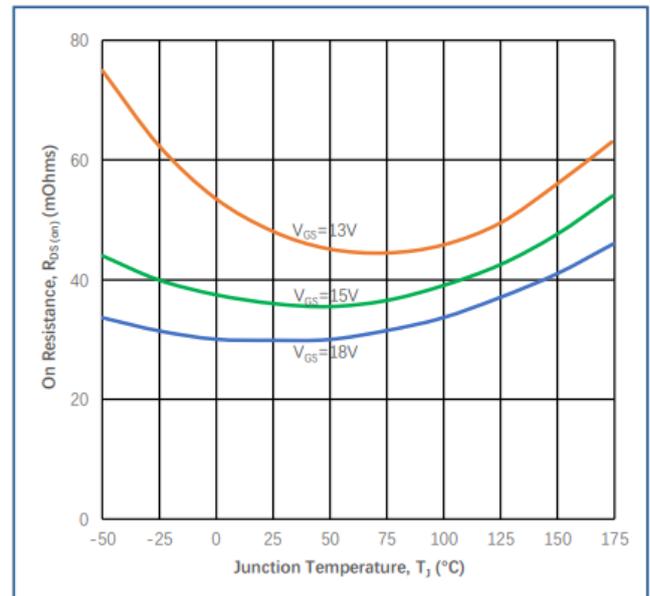


Figure 4
On-Resistance vs. Temperature

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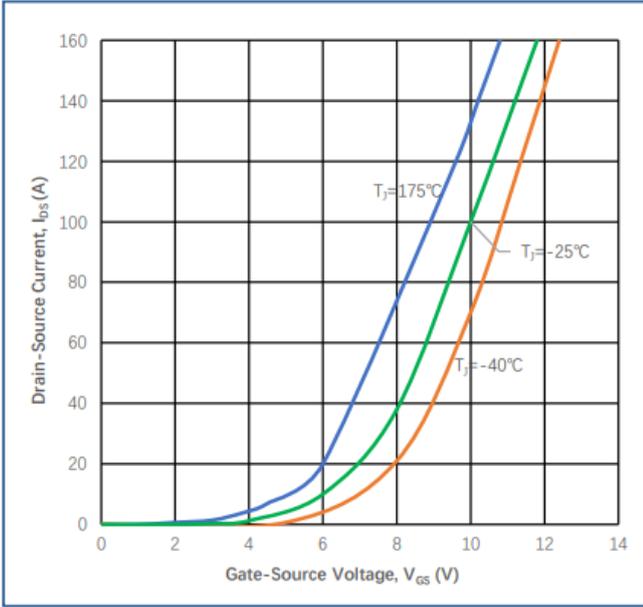


Figure 5
Transfer Characteristic

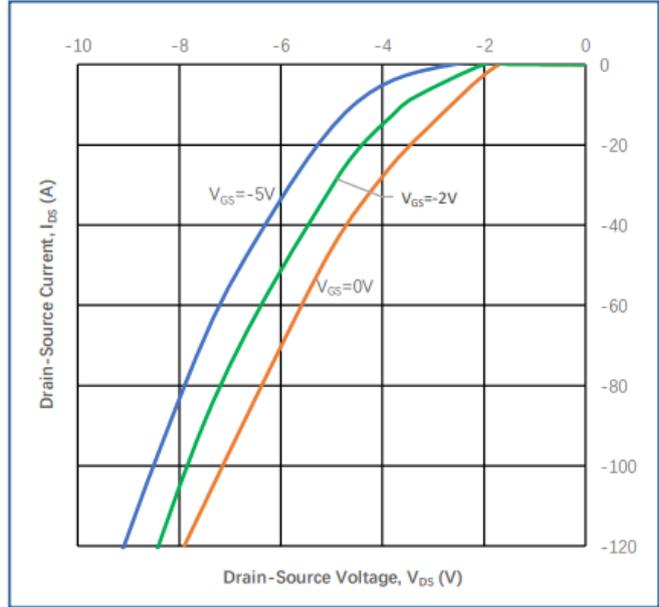


Figure 6
Body Diode Characteristic at 25°C

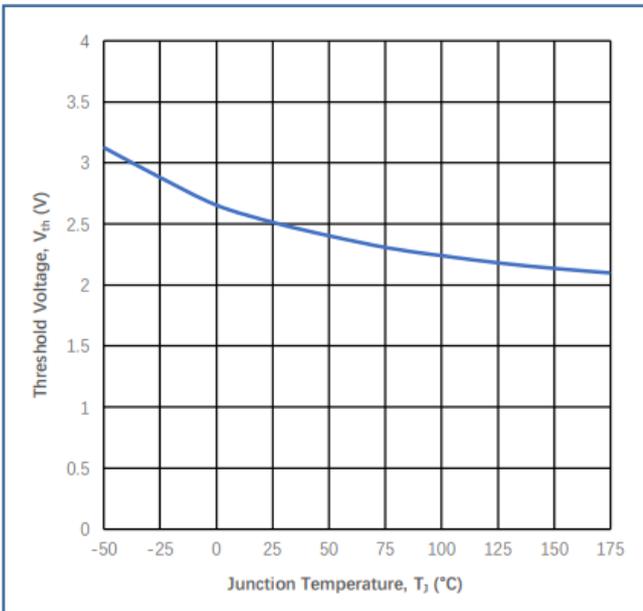


Figure 7
Threshold Voltage vs. Temperature

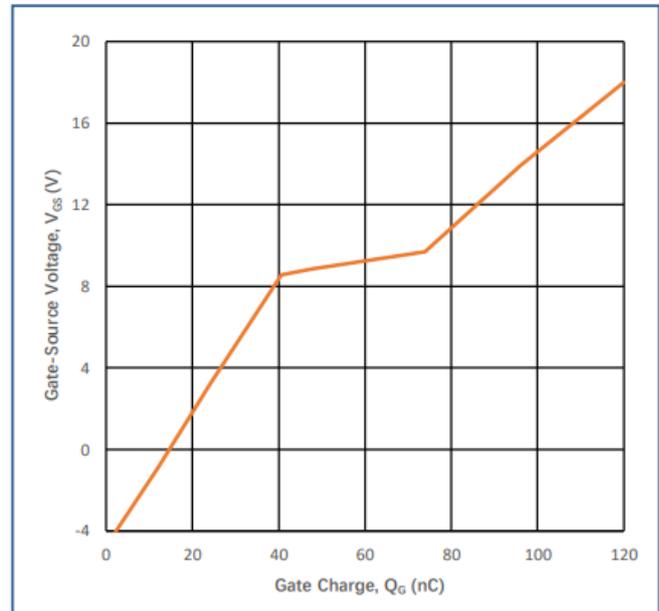


Figure 8
Gate Charge Characteristics

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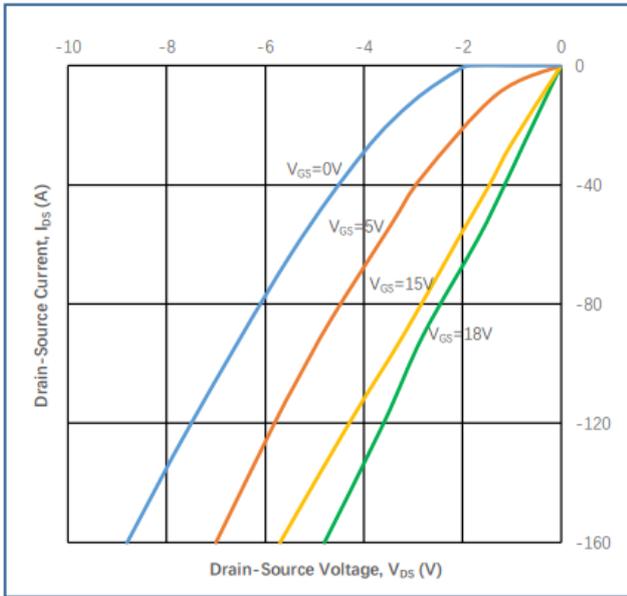


Figure 9
3rd Quadrant Characteristic at 25°C

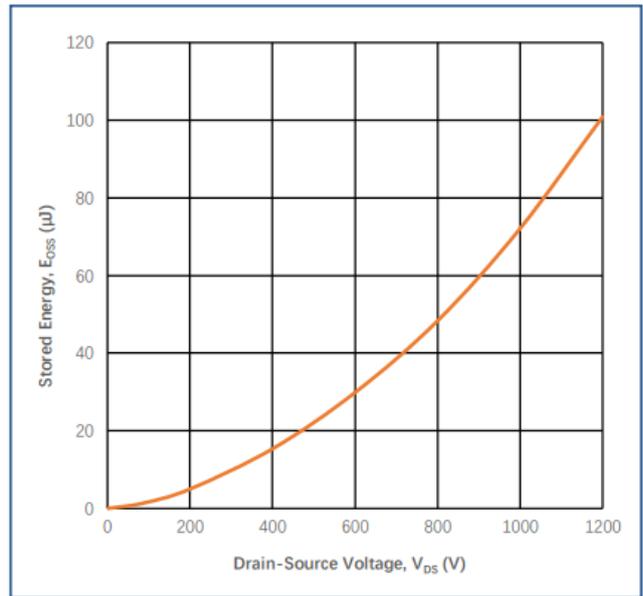


Figure 10
Output Capacitor Stored Energy

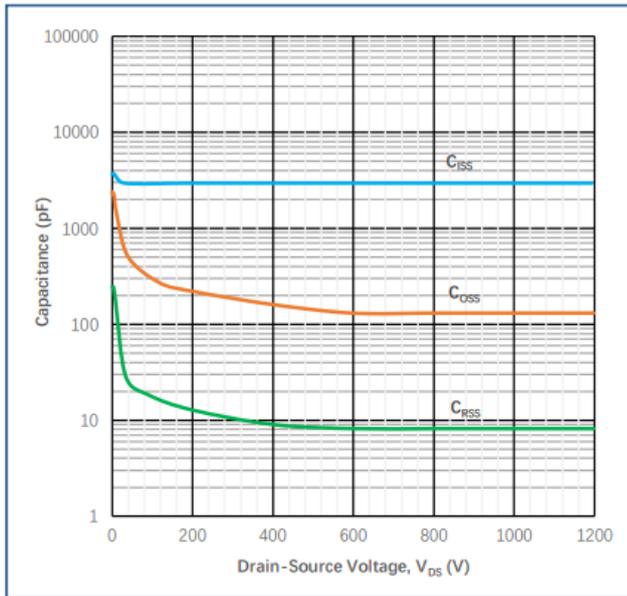


Figure 11
Capacitances vs. Drain-source

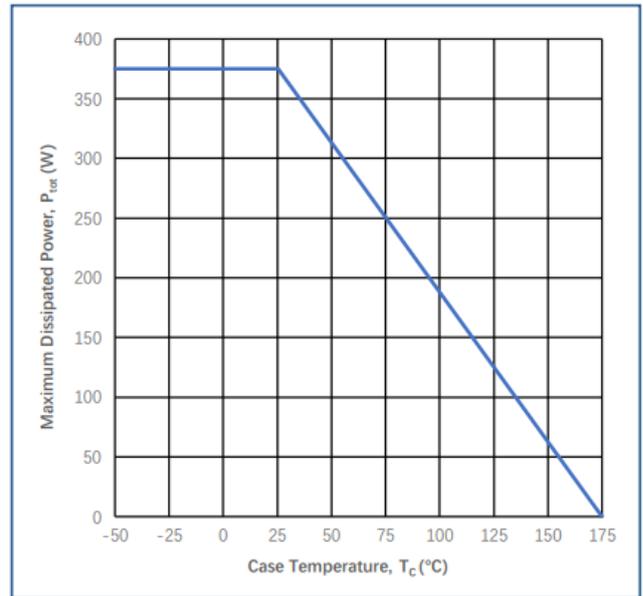


Figure 12
Max Power Dissipation Derating vs T_c

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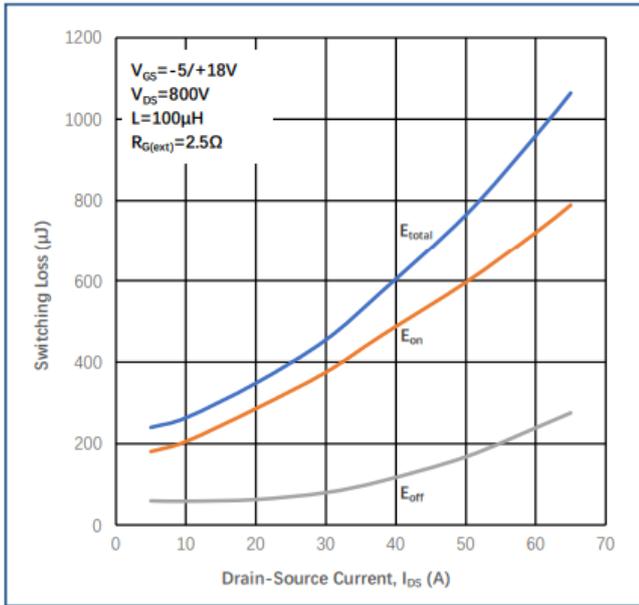


Figure 13
Switching Energy vs. Drain Current

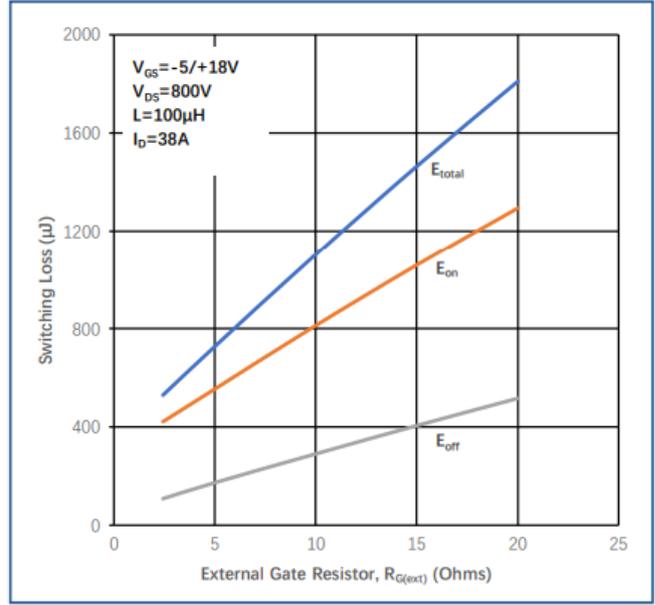


Figure 14
Switching Energy vs. $R_{G(ext)}$

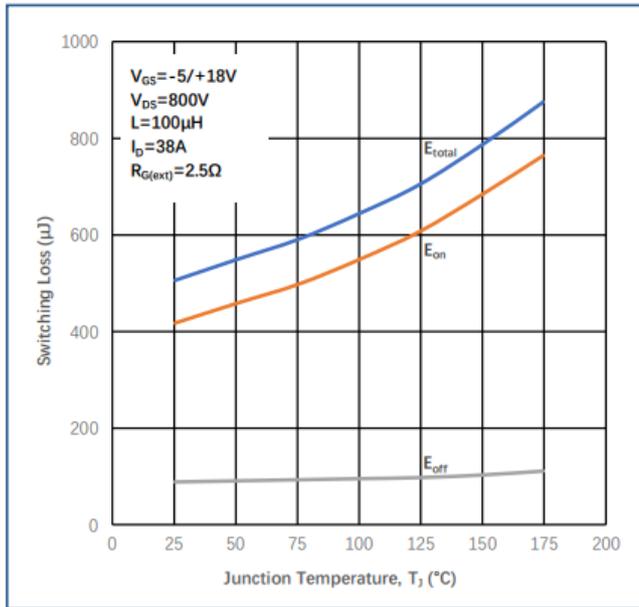


Figure 15
Switching Energy vs. Temperature

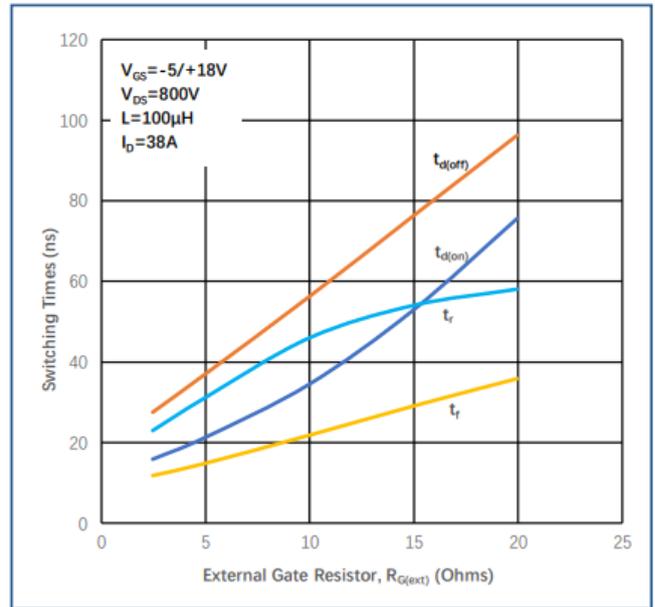


Figure 16
Switching Times vs. $R_{G(ext)}$

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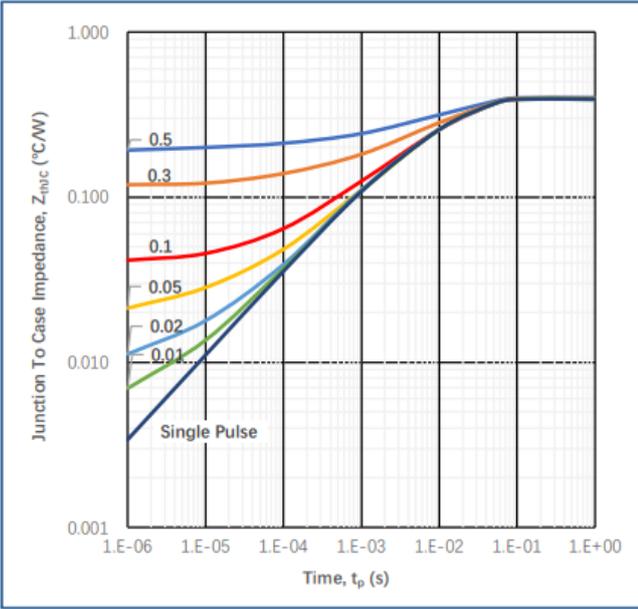


Figure 17
Transient Thermal Impedance

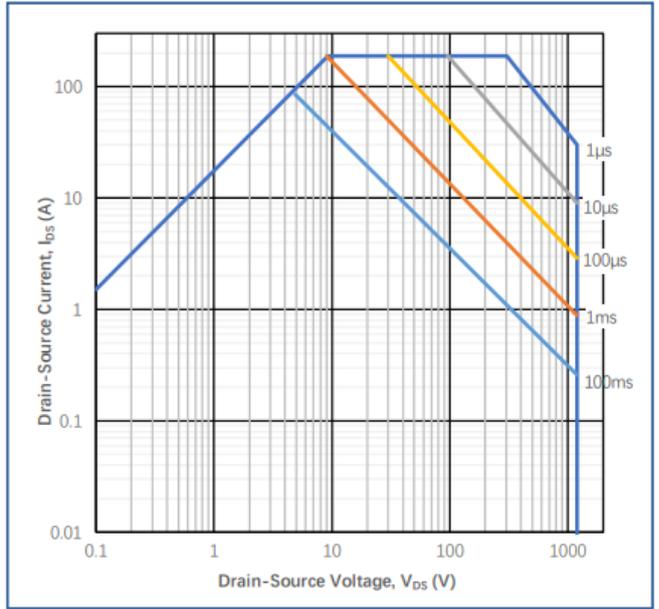
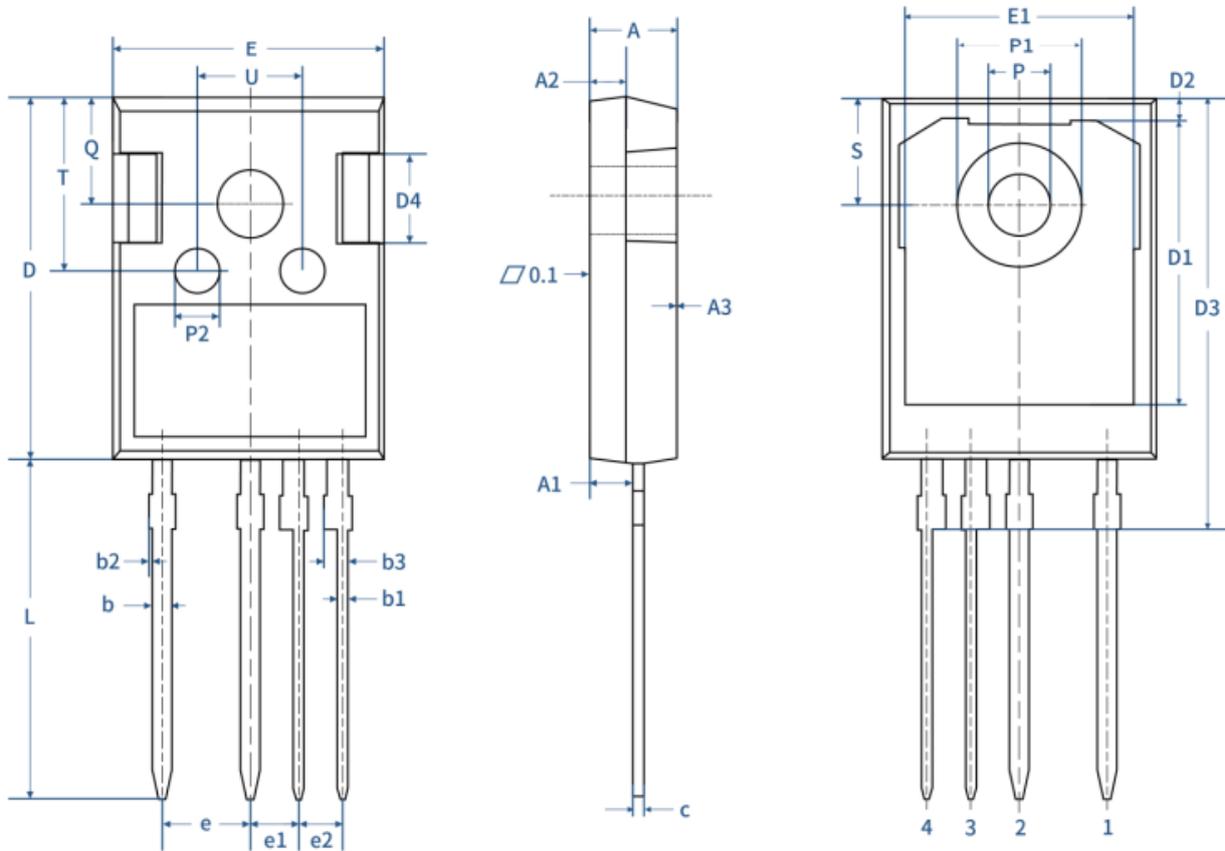


Figure 18
Safe Operating Area

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Symbol	Millimeters		Symbol	Millimeters	
	Min.	Max.		Min.	Max.
A	4.9	5.1	E	15.7	15.9
A1	2.31	2.51	E1	13.1	13.5
A2	1.9	2.1	e	5.08	
A3	0.05	0.25	e1	2.79	
b	1.1	1.3	e2	2.54	
b1	0.65	0.79	L	19.8	20.1
b2	-	0.2	P	3.5	3.7
b3	1.34	1.44	P1	7	7.4
c	0.58	0.66	P2	2.4	2.6
D	20.9	21.1	Q	5.6	6
D1	16.25	16.85	S	6.15	-
D2	1.05	1.35	T	9.8	10.2
D3	24.97	25.27	U	6	6.4
D4	4.9	5.1			

Pin	Symbol	Description
1	D	Drain
2	S	Power Source
3	S	Driver Source
4	G	Gate
mb	D	Mounting Base; Connected to Drain

Note:

1. All metal surfaces are Sn plated (matte), except area of cut.
2. Burr or mold flash size (0.5 mm) is not included in the dimensions.

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Revision version	Description	Date
1	Initial	01.2026